Notice of References Cited Application/Control No. 10/735,425 Examiner Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination LEE ET AL. Art Unit Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,992,696	01-2006	Albertelli, Lawrence E.	348/188
*	В	US-2004/0212680	10-2004	Schroeder et al.	348/188
	С	US-			
	۵	US-			· ·
	Е	US-			
	F	US-			
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	Ι	US-			
	Ι	US-			
	J	US-			
·	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000224615 A	08-2000 ·	Japan	MIYAGAWA et al.	
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<u> </u>	Q					
	R					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.